## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10524444	MOCHIZUKI ET AL.
Examiner	Art Unit
HENOK G HEVI	2627

SEARCHED					
Class	Subclass	Date	Examiner		
369	47.1	05/05/2008	Henok Heyi		
	53.1	05/05/2008	Henok Heyi		
	53.2	05/05/2008	Henok Heyi		
	53.41	05/05/2008	Henok Heyi		
	59.1	05/05/2008	Henok Heyi		

SEARCH NOTES				
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Searched EAST and refered to International Search Report (ISR).	05/05/2008	Henok Heyi		

INTERFERENCE SEARCH				
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